

## P-Channel Trench Power MOSFET

 Lead Free Package and Finish

### General Description

The RS30P65D uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as -5V. This device is suitable for use as a wide variety of applications.

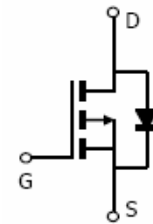
### Features

- $V_{DS} = -30V, I_D = -65A$   
 $R_{DS(ON)} < 9m\Omega @ V_{GS} = -10V$   
 $R_{DS(ON)} < 16m\Omega @ V_{GS} = -5V$
- High Power and current handling capability
- Lead free product is acquired
- Surface Mount Package

### Application

- DC-DC converter
- Load switch
- Power management

**100% UIS TESTED!**  
**100%  $\Delta V_{ds}$  TESTED!**



Schematic Diagram



TO-252 top view

### Package Marking and Ordering Information

Device Marking	Device	Device Package
RS30P65D	RS30P65D	TO-252

**Table 1. Absolute Maximum Ratings ( $T_A=25^\circ C$ )**

Symbol	Parameter	Value	Unit
$V_{DS}$	Drain-Source Voltage ( $V_{GS}=0V$ )	-30	V
$V_{GS}$	Gate-Source Voltage ( $V_{DS}=0V$ )	$\pm 25$	V
$I_D$	Drain Current-Continuous( $T_c=25^\circ C$ )	-65	A
	Drain Current-Continuous( $T_c=100^\circ C$ )	-45	A
$I_{DM (pluse)}$	Drain Current-Continuous@ Current-Pulsed <b>(Note 1)</b>	-260	A
$E_{AS}$	Avalanche energy <b>(Note 2)</b>	500	mJ
$P_D$	Maximum Power Dissipation( $T_c=25^\circ C$ )	83	W
	Maximum Power Dissipation( $T_c=100^\circ C$ )	41	W
$T_J, T_{STG}$	Operating Junction and Storage Temperature Range	-55 To 175	$^\circ C$

**Table 2. Thermal Characteristic**

Symbol	Parameter	Typ	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case	--	1.8	$^\circ C/W$

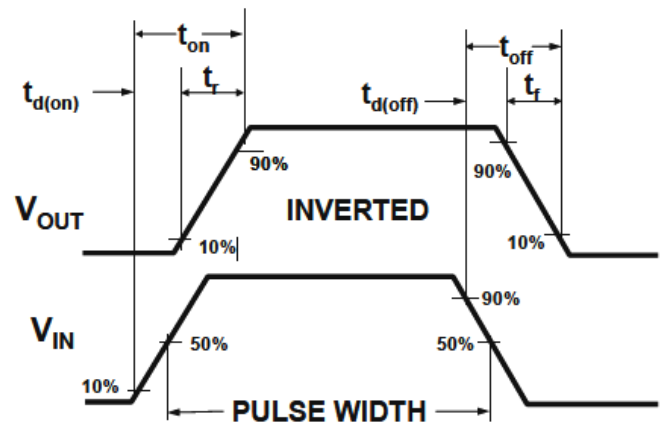
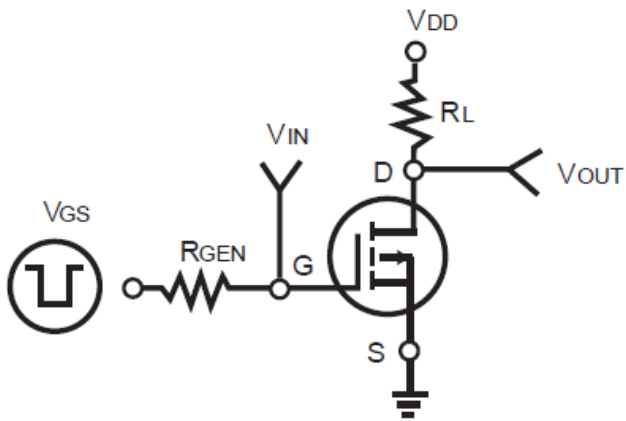
**Table 3. Electrical Characteristics (TA=25°C unless otherwise noted)**

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
<b>On/Off States</b>						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V I <sub>D</sub> =-250μA	-30			V
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-30V, V <sub>GS</sub> =0V			-1	μA
I <sub>GSS</sub>	Gate-Body Leakage Current	V <sub>GS</sub> =±25V, V <sub>DS</sub> =0V			±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	V <sub>DS</sub> =V <sub>GS</sub> , I <sub>D</sub> =-250μA	-1	-1.8	-3	V
g <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-10A	20	28		S
R <sub>DS(ON)</sub>	Drain-Source On-State Resistance	V <sub>GS</sub> =-10V, I <sub>D</sub> =-20A		7.1	9	mΩ
		V <sub>GS</sub> =-5V, I <sub>D</sub> =-15A		10	16	mΩ
<b>Dynamic Characteristics</b>						
C <sub>iss</sub>	Input Capacitance	V <sub>DS</sub> =-15V, V <sub>GS</sub> =0V, f=1.0MHz		3570		pF
C <sub>oss</sub>	Output Capacitance			435		pF
C <sub>rss</sub>	Reverse Transfer Capacitance			175		pF
<b>Switching Times</b>						
t <sub>d(on)</sub>	Turn-on Delay Time	V <sub>DD</sub> =-15V, I <sub>D</sub> =-1A, R <sub>L</sub> =15Ω V <sub>GS</sub> =-10V, R <sub>G</sub> =2.5Ω		16		nS
t <sub>r</sub>	Turn-on Rise Time			14		nS
t <sub>d(off)</sub>	Turn-Off Delay Time			50		nS
t <sub>f</sub>	Turn-Off Fall Time			22		nS
Q <sub>g</sub>	Total Gate Charge	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-10A		58		nC
Q <sub>gs</sub>	Gate-Source Charge			9		nC
Q <sub>gd</sub>	Gate-Drain Charge			14		nC
<b>Source-Drain Diode Characteristics</b>						
I <sub>SD</sub>	Source-Drain Current(Body Diode)				-50	A
V <sub>SD</sub>	Forward on Voltage	V <sub>GS</sub> =0V, I <sub>S</sub> =-10A			-1.2	V

Notes 1.Repetitive Rating: Pulse width limited by maximum junction temperature

Notes 2.EAS condition: T<sub>J</sub>=25°C, V<sub>BD</sub>=30V, V<sub>G</sub>=-10V, R<sub>G</sub>=25Ω

## Switch Time Test Circuit and Switching Waveforms:



## TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS (Curves)

Figure1. Power Dissipation

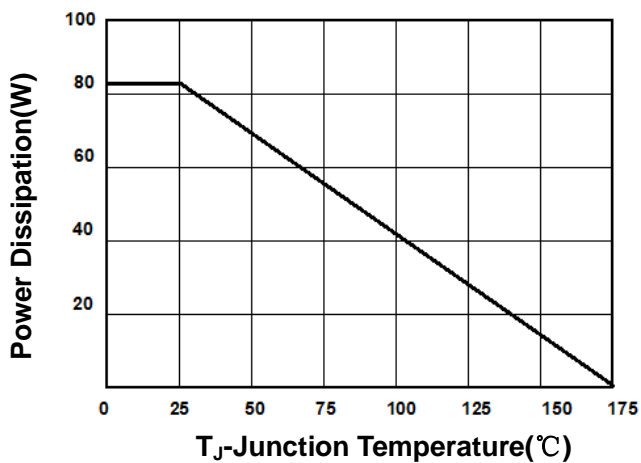


Figure2. Drain Current

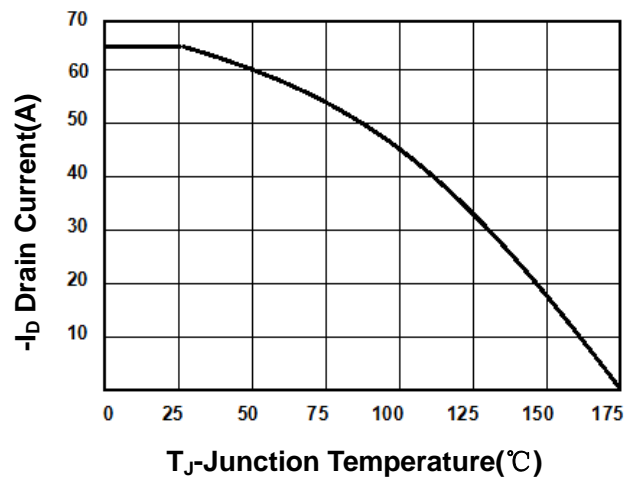


Figure3. Output Characteristics

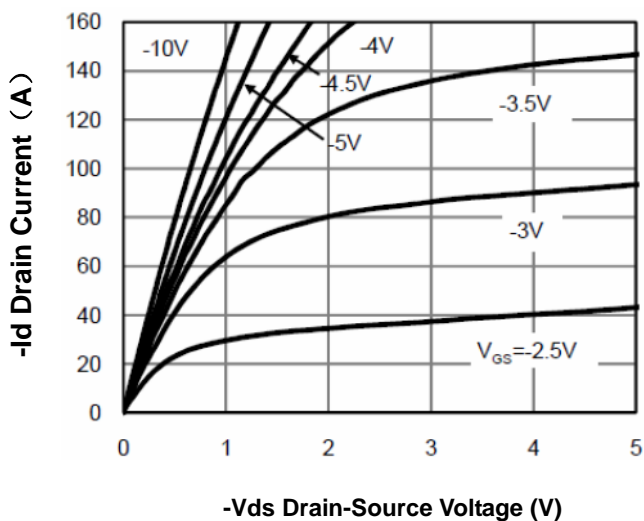


Figure4. Transfer Characteristics

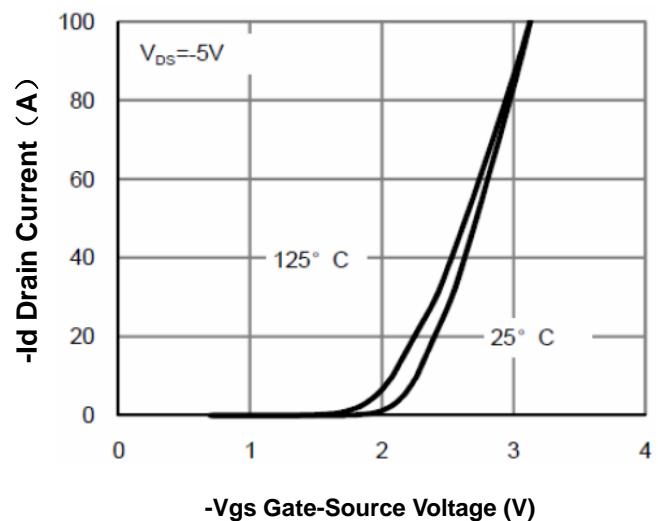


Figure5. Capacitance

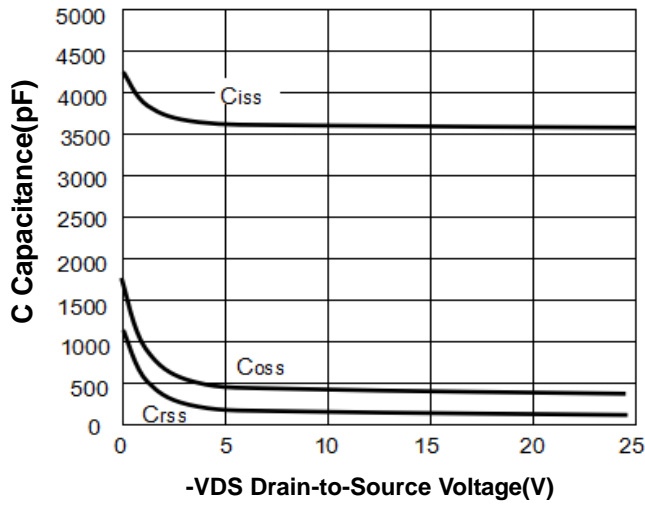


Figure6.  $R_{DS(ON)}$  vs Junction Temperature

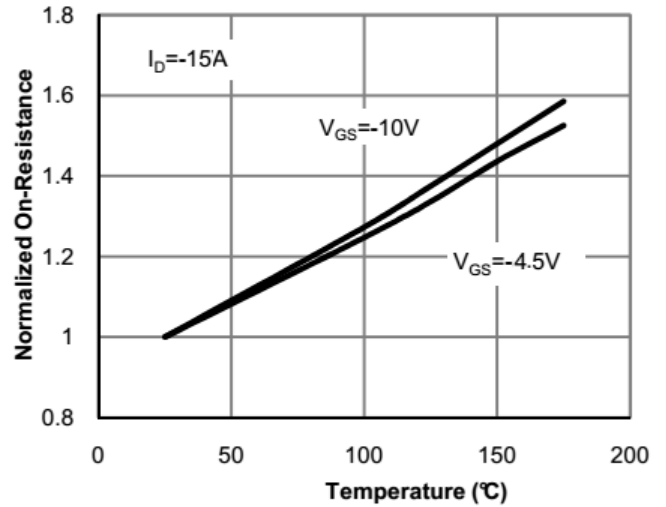


Figure7. Max  $BV_{DSS}$  vs Junction Temperature

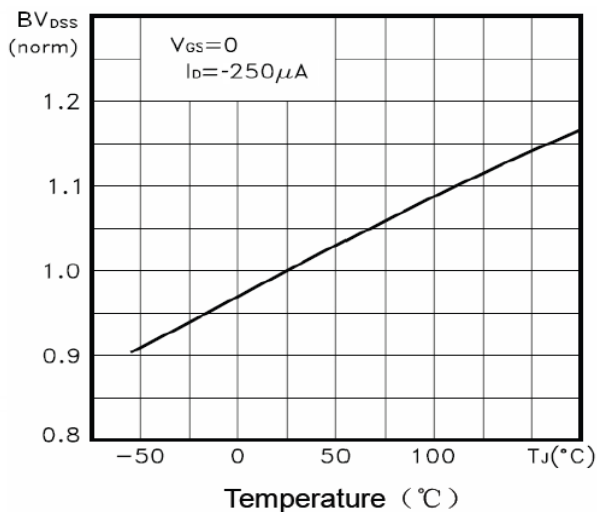


Figure8.  $V_{GS(th)}$  vs Junction Temperature

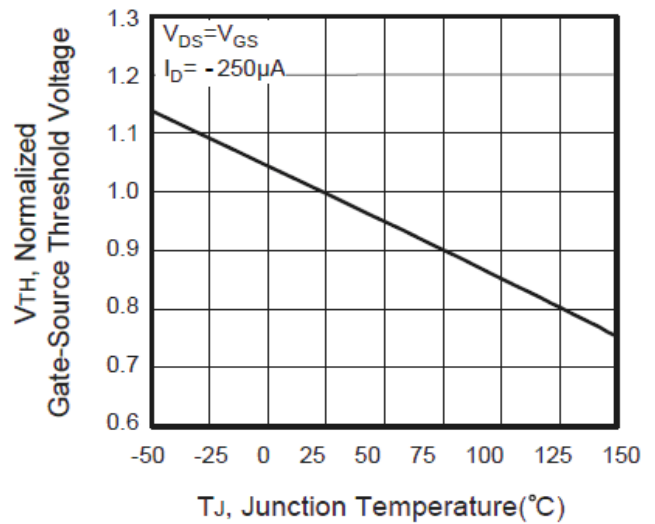


Figure9. Gate Charge Waveforms

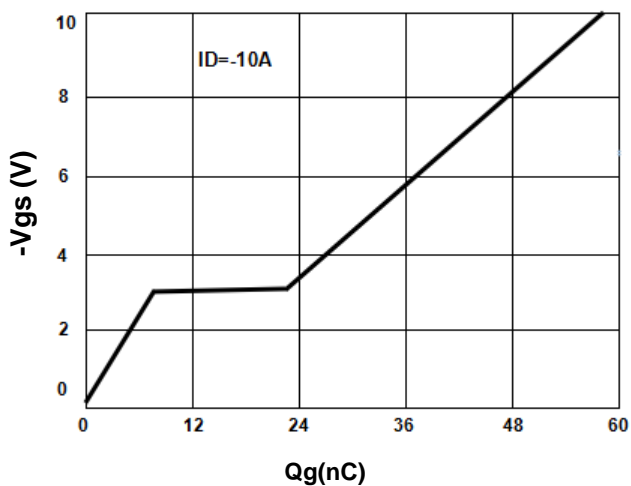


Figure10. Maximum Safe Operating Area

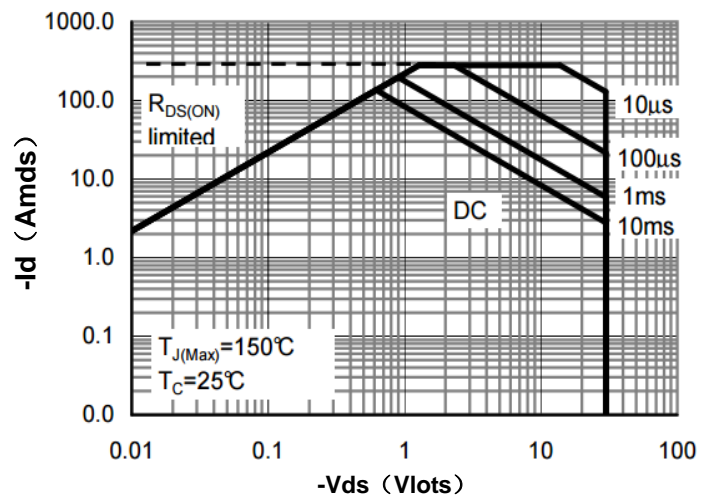
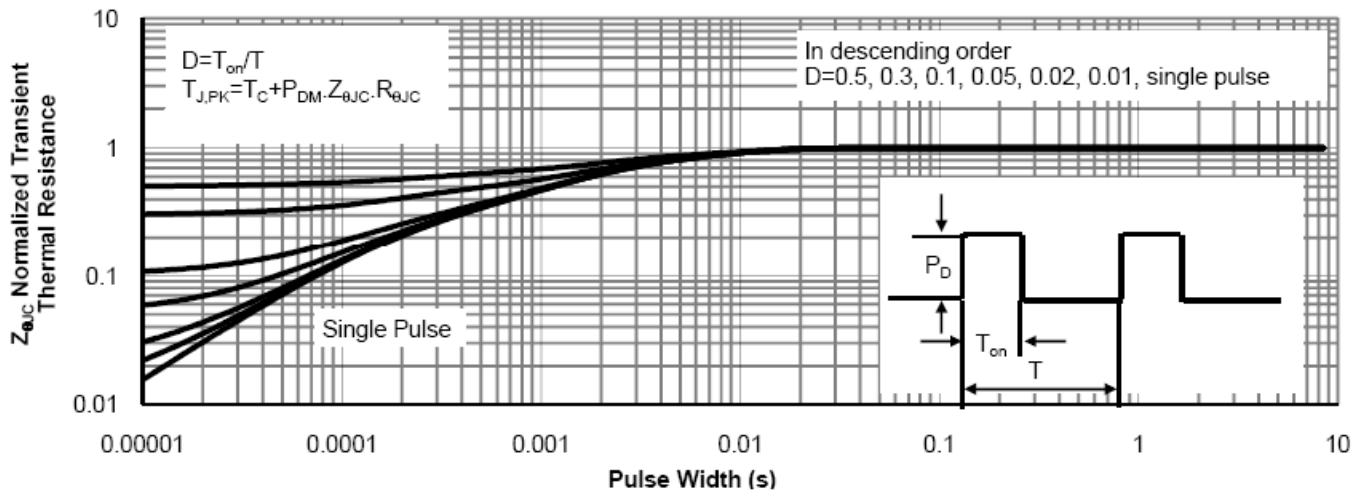
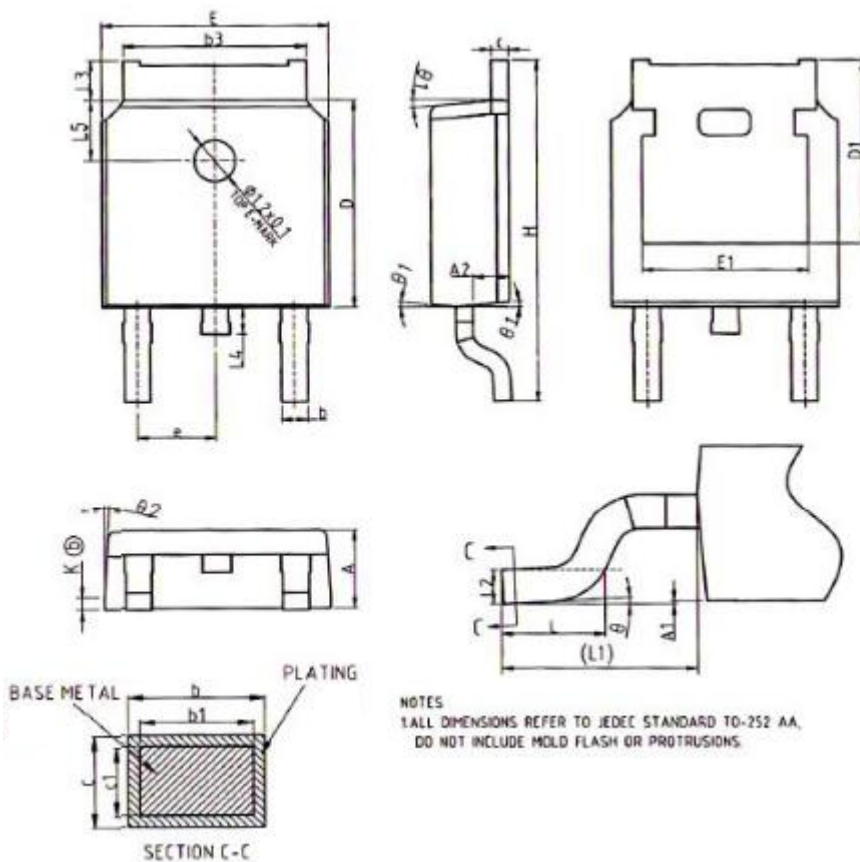


Figure 11. Normalized Maximum Transient Thermal Impedance



## TO-252 Package Information



COMMON DIMENSIONS			
SYMBOL	mm		
	MIN	NOM	MAX
A	2.20	2.30	2.38
A1	0.00	-	0.10
A2	0.97	1.07	1.17
b	0.72	0.78	0.85
b1	0.71	0.76	0.81
b3	5.23	5.33	5.46
c	0.47	0.53	0.58
c1	0.46	0.51	0.56
D	6.00	6.10	6.20
D1	5.30REF		
E	6.50	6.60	6.70
E1	4.70	4.83	4.92
e	2.286BSC		
H	9.90	10.10	10.30
L	1.40	1.50	1.70
L1	2.90REF		
L2	0.51BSC		
L3	0.90	-	1.25
L4	0.60	0.80	1.00
L5	1.70	1.80	1.90
theta	0° - 8°		
theta 1	5°	7°	9°
theta 2	5°	7°	9°
K	0.40REF		

NOTES  
 1. ALL DIMENSIONS REFER TO JEDEC STANDARD TO-252 AA.  
 DO NOT INCLUDE MOLD FLASH OR PROTRUSIONS.

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